NSN 5962-01-424-3083

Memory Microcircuit - Page 1 of 1



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End Application:
Was/wes test
Inclosure Configuration:
Dual-in-line
Time Rating Per Chacteristic:
25.00 nanoseconds input to output access
Memory Device Type:
Pal
Special Features:
Programmed pal22v10
Terminal Type And Quantity:
24 printed circuit
Shelf Life:
N/a
Unit Of Measure:
Demilitarization:
Yes - demil/mli
Fiig:
A458a0